TOSHIBA Photocoupler GaAs Ired & Photo-Transistor

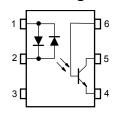
TLP330

Programmable Controllers AC / DC-Input Module Telecommunication

The TOSHIBA TLP330 consists of a photo–transistor optically coupled to two gallium arsenide infrared emitting diode connected inverse parallel in a six lead plastic DIP package. This is suitable for application of AC input current up to 150mA.

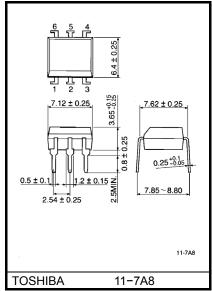
- If maximum rating: ±150mA
- Collector-Emitter voltage: 55V(min.)
- Current transfer ratio: 25% (min.)($I_F = \pm 20$ mA)
- Isolation voltage: 5000Vrms (min.)
- UL recognized: UL1577, file no. E67349

Pin Configurations (top view)



- 1: Anode, cathode
- 2: Cathode, anode
- 3: NC
- 4: Emitter
- 5: Collector
- 6: Base

Unit in mm



Weight: 0.39 g

Absolute Maximum Ratings (Ta = 25°C)

	Characteristic	Symbol	Rating	Unit
Q	Forward current	lF	±150	mA
	Forward current derating (Ta ≥ 25°C)	ΔI _F /°C	-1.5	mA /°C
LED	Peak forward current (100µs pulse,100pps)	I _{FP}	±1	А
	Junction temperature	Tj	125	°C
	Collector-emitter voltage	V _{CEO}	55	V
	Collector-base voltage	V _{CBO}	80	V
	Emitter-collector voltage	V _{ECO}	7	V
ctor	Emitter-base voltage	V _{EBO}	7	V
Detector	Collector current	Ic	80	mA
	Power dissipation	PC	150	mW
	Power dissipation derating (Ta ≥ 25°C)	ΔP _C /°C	-1.5	mW /°C
	Junction temperature	Tj	125	°C
Sto	rage temperature range	T _{stg}	-55~125	°C
Оре	erating temperature range	T _{opr}	-55~100	°C
Lea	d soldering temperature (10s)	T _{sol}	260	°C
Tota	al package power dissipation	P _T	250	mW
Tota	al package power dissipation derating (Ta≥25°C)	ΔP _T /°C	-2.5	mW /°C
Isol	ation voltage (AC, 1 min, R.H. ≤ 60%) (Note 1)	BVS	5000	Vrms

Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

(Note 1) Device considered a two terminal device: Pins 1, 2 and 3 shorted together and pins 4, 5 and 6 shorted together.

Recommended Operating Conditions

Characteristic	Symbol	Min.	Тур.	Max.	Unit
Supply voltage	V _{CC}	_	5	24	V
Forward current	I _{F(RMS)}	_	20	120	mA
Collector current	IC	_	1	10	mA
Operating temperature	T _{opr}	-25	_	85	°C

Note: Recommended operating conditions are given as a design guideline to obtain expected performance of the device. Additionally, each item is an independent guideline respectively. In developing designs using this product, please confirm specified characteristics shown in this document.

Individual Electrical Characteristics (Ta = 25°C)

	Characteristic	Symbol	Condition	Min.	Тур.	Max.	Unit
LED	Forward voltage	V _F	I _F = ±100 mA	_	1.4	1.7	V
	Forward current	l _F	V _F = ±0.7V	_	2.5	20	μΑ
	Capacitance	C _T	V = 0, f = 1 MHz	_	100	_	pF
ctor	Collector–emitter breakdown voltage	V _(BR) CEO	I _C = 0.5 mA	55	_	_	V
	Emitter-collector breakdown voltage	V _(BR) ECO	I _E = 0.1 mA	7	_	_	V
	Collector-base breakdown voltage	V _(BR) CBO	I _C = 0.1 mA	80	_	_	V
	Emitter-base breakdown voltage	V _(BR) EBO	I _E = 0.1 mA	7	_	_	V
Detector	Collector dark current	I _{CEO}	V _{CE} = 24 V	_	10	100	nA
			V _{CE} = 24 V, Ta = 85°C	_	2	50	μA
	Collector dark current	ICER	V_{CE} = 24 V, Ta = 85°C R _{BE} = 1M Ω	-	0.5	10	μΑ
	Collector dark current	I _{CBO}	V _{CE} = 10V	1	0.1	_	nA
	DC forward current gain	h _{FE}	V _{CE} = 5 V, I _C = 0.5mA	_	400	_	_
	Capacitance (collector to emitter)	C _{CE}	V = 0, f = 1 MHz	_	10	_	pF

Coupled Electrical Characteristics (Ta = 25°C)

Characteristic	Symbol	Condition	MIn.	Тур.	Max.	Unit
Current transfer ratio	I _C / I _F	I_F = ±20 mA V_{CE} = 1 V	25	_	_	%
	I _C / I _{F(high)}	$I_F = \pm 100 \text{ mA V}_{CE} = 1 \text{ V}$	20	_	80	%
Base photo-current	I _{PB}	$I_F = \pm 5 \text{ mA}, V_{CB} = 5 \text{ V}$	1	10	_	μA
Collector-emitter	V _{CE} (sat)	I _C = 2.4 mA, I _F = 20 mA	1	1	0.4	V
saturation voltage		I _C = 2.4 mA, I _F = ±100 mA	1	1	0.4	
Off-state collector current	I _{C(off)}	$V_F = \pm 0.7V$, $V_{CE} = 24 V$	1	1	10	μA
CTR symmetry	I _{C (ratio)}	I _C (I _F = -20mA) / I _C (I _F = +20mA)	0.5	1	2	_

3 2007-10-01

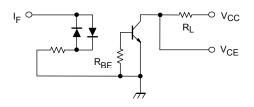
Isolation Characteristics (Ta = 25°C)

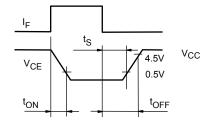
Characteristic	Symbol	Test Condition	Min.	Тур.	Max.	Unit
Capacitance (input to output)	CS	V _S = 0, f = 1 MHz	_	0.8	_	pF
Isolation resistance	R _S	V _S = 500 V, R.H. ≤ 60%	5×10 ¹⁰	10 ¹⁴	_	Ω
		AC, 1 minute	5000	_	_	Vrms
Isolation voltage	BV_S	AC, 1 second, in oil	_	10000	_	Vrms
		DC, 1 minute, in oil	_	10000	_	Vdc

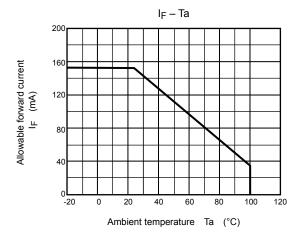
Switching Characteristics (Ta = 25°C)

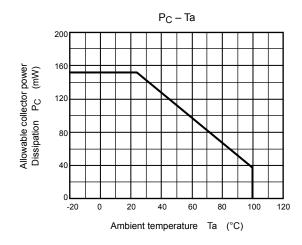
Characteristic	Symbol	Test Condition	Min.	Тур.	Max.	Unit
Rise time	t _r		_	2	_	
Fall time	t _f	V _{CC} = 10 V I _C = 2 mA	_	3	_	μs
Turn-on time	t _{on}	$R_L = 100\Omega$	_	3	_	μδ
Turn-off time	t _{off}		_	3	_	
Turn-on time	t _{ON}	R_L = 1.9 k Ω (Fig.1) R_{BE} = OPEN V_{CC} = 5 V, I_F = ±16 mA	_	2	_	
Storage time	t _S		_	15	_	μs
Turn-off time	t _{OFF}		_	25	_	
Turn-on time	t _{ON}	R_L = 1.9 kΩ (Fig.1) R_{BE} = 220kΩ V_{CC} = 5 V, I_F = ±16 mA	_	2	_	
Storage time	t _S		_	12	_	μs
Turn-off time	toff		_	20	_	

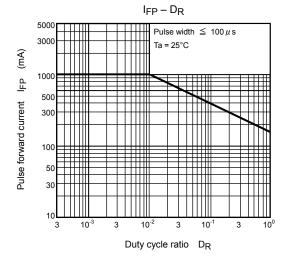
Fig. 1 Switching time test circuit

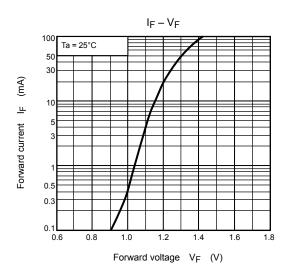


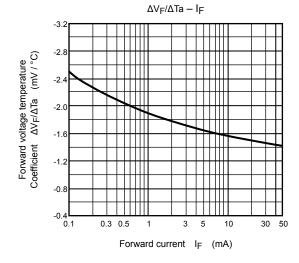


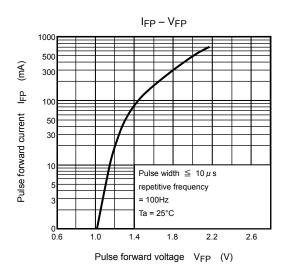












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6